VASE: INSTRUMENT TO STUDY BIAXIAL ORGANIC MOLECULAR THIN FILMS

Andreea BERARU

Abstract: Spectroscopic ellipsometry was employed to determine the complex refractive index and dielectric function of a N,N'-dimethylperylene-3,4,9,10-dicarboximide (DiMe-PTCDI) film grown on S-GaAs(100). The optically biaxial film shows strong anisotropy. From the investigations we can conclude that the DiMe-PTCDI molecules in the organic layer are predominantly oriented with their long axis parallel to the [011] direction of the GaAs substrate and tilted with their molecular plane with respect to the substrate plane.

Key words: generalised ellipsometry, anisotropy, organic molecular thin films.

^{*} Transilvania University of Brasov.